

10/537477

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APPLICANT'S ART CITATION (Use several sheets if necessary)	Application	No. P/2850-110
	Applicant Toshiharu KOBAYASHI et al	
	Filing Date	Group Art Unit

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate
/C.F./	US-4,582,548	04-1986	Kenneth Harris	148	404	
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/C.F./	US-5,366,695	11-1994	Gary Erickson	420	448	
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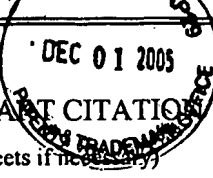
FOREIGN PATENT DOCUMENTS

	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner /Caitlin Fogarty/	Date Considered 09/06/2007
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 APPLICANT'S ART CITATION (Use several sheets if necessary)		Application 10/537,477		OFGS File No. P/2850-110			
		Applicant Toshiharu Kobayashi, et al.					
		Filing Date June 3, 2005		Group Art Unit 1742			
U.S. PATENT DOCUMENTS (not submitted for applications filed after 6/30/03)							
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate	
/C.F./	US-4,719,080	01-1988	Duhl et al.	420	443		
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	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
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	07-274171	10-1995	Japan			X	
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	Japanese Office Action (with translation).						
/C.F./	C. Magazine, August 2001, p. 111-116 "Image Compression Algorithm 2 Entropy Coding 'SHANON-FANO CODING AND HUFFMAN CODING'" (In Japanese - English abstract attached)						
/C.F./	C. Magazine, September 2001, p. 95-100 "Image Compression Algorithm 3 'ELIAS CODING AND ARITHMETIC CODING'" (In Japanese - English abstract attached)						
/C.F./	C. Magazine July 2002 p. 13-35 "Data Compression, from the fundamentals to applications Algorithm" (In Japanese - English abstract attached)						
Examiner /Caitlin Fogarty/			Date Considered 09/06/2007				
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APPLICANT'S ART CITATION <small>(Use several sheets if necessary)</small>		Application 10/537,477		OFGS File No. P/2850-110		
		Applicant Toshiharu KOBAYASHI et al.				
		Filing Date June 2, 2005		Group Art Unit 1742		
U.S. PATENT DOCUMENTS (not submitted for applications filed after 6/30/03)						
Examiner NOV 20 2006	Document Number	Date MM-YYYY	Name	Class	Sub- class	Filing Date If Appropriate
	US-					
	US-					
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FOREIGN PATENT DOCUMENTS						
	Document Number	Date MM-YYYY	Country	Class	Sub- class	Translation: Yes No
/C.F./	0 663 462 A1	12-1994	EPO			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
	International Search Report dated October 5, 2006.					
Examiner	/Caitlin Fogarty/		Date Considered 09/06/2007			
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